PROCEEDINGS OF SPIE

Integrated Optics: Devices, Materials, and Technologies XXVII

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Editors

30 January – 2 February 2023
San Francisco, California, United States

Sponsored and Published by
SPIE

Volume 12424

Proceedings of SPIE 0277-786X, V. 12424

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Integrated Optics: Devices, Materials, and Technologies XXVII, edited by Sonia M. García-Blanco, Pavel Cheben, Proc. of SPIE Vol. 12424, 1242401 · © 2023 SPIE
0277-786X · doi: 10.1117/12.2678600

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Author(s), "Title of Paper," in *Integrated Optics: Devices, Materials, and Technologies XXVII*, edited by Sonia M. García-Blanco, Pavel Cheben, Proc. of SPIE 12424, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510659537
ISBN: 9781510659544 (electronic)

Published by
SPIE
P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time)
SPIE.org
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